SHEET 1 OF

LISTA	FART CITE) BY APPI		ATTY, DOCKET NO. P-0588			APPLN. SERIAL NO. 10/696,997				
	TO 1	APPLICANT(S)	Jae-Che	ol LEE							
DEC	0 7 2005	FILING DATE October 31	October 31, 2003			GROUP 2631					
	PADENA STATE OF THE STATE OF TH	Julius Julia	PATENT DO	CUMENTS							
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INV	ENTOR NAME	CLASS	SUBCLASS	FILI DA				
	,										
	·										
		US: PATENT	APPLICATI	ON PUBLICATION	SIUN		點調				
	*PATENT APPLN. PUB. NO.	*PUB. DATE	•,	APPLICANT	CLASS	SUBCLASS					
					 		l I	_			
		i Historijusij	I PATENTIARE	LICATIONS				Ŧ.			
	*APPLN. NO.	*FILING DATE	*INVENTOR		CLASS	SUBCLASS	Charles and	COR I SCHOOL			
						 					
	Medical Company	FOREIG	GN PATENT	DOCUMENTS				和極			
EXAMINER'S INITIALS	PATENT NO.	DATE		COUNTRY	CLASS	SUBCLASS	Trans Yes				
SL	WO 01/74103 A1	20/04/2001		glish Abstract &	-		X	No			
SL	JP 2002-246955	08/30/2002	Japanese F				X				
SL	JP 04-053324	02/20/1992	Japan (English Abstract & Japanese Full Text)				Х				
					-						
OTHE	RART (Including A	uthör, Title, D	ı ate, Pertinen	t Pages Rublishe	r. Place of	L Publication:	Etc.)	100			
SL	HER/ART: (Including Author: Title Date: Pertinent Pages Publisher, Place of Publication Etc.) 3rd Generation Partnership Project; Technical Specification Group Radio Access Network; Spreading and Modulation (TDD) (Release 4) – 3GPP TS 25.223 V4.4.0 (2002-03)										
SL	CWTS, "Frame Structure for Low Chip Rate TDD Option." TSG-RAN Working Group 1, Meeting 12, TSGR1 (00)0491, Seoul, Korea, April 10-13, 2000.										
SL	Copy of Japanese Office Action.										
EXAMINER	/Siu Lee/ DATE CONSIDERED 01/12/2007										

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

\\fk4\Documents\2000\2000\688\81665.doc

LIST OF ART CITED BY ARTELECANT (PTO-1449) SEP 0 8 2005					ATTY, DOCKET NO. P-0588		APPLN. SERIAL NO. 10/696,997		
					APPLICANT(S) Jae-Cheol LEE				
					FILING DATE October 31, 2003	GROUP 2631			
U.S. PATENT	DOCUMENTS	10	TE TRADEUR						
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	·		SUBCLASS	FILI DA			
		US PATEN	NT APPLICA	TI	ON PUBLICATION	L	1	L	
	*PATENT APPLN. PUB. NO.	*PUB. DATE			PLICANT	CLASS	SUBCLASS		
			J.S. PATENT AI	PP	LICATIONS		ļ		
•	*APPLN. NO.	'FILING DATE	•1	N	/ENTOR	CLASS	SUBCLASS		
			05:01:01:01:51		200111151170				
EXAMINER'S	1	T .	REIGN PATEN		DOCUMENTS		1	Trans	iation
INITIALS	ALS PATENT NO. DATE CN 1311566 09/05/2001 0			COUNTRY China (Full Text & English Abstract)		CLASS	SUBCLASS	Yes	No
							·		
07:17	ADT (1)		2-1-2	_	4.0	- DI	-6 Dubit == **		
SL ST	Chinese Office				t Pages, Publishe 10, 2005	er, Place	or Publicatio	n, Etc.	
				_					
						 			
EXAMINER	/Siu Lee/		···	D	ATE CONSIDERE	D 0	1/12/2007		
PANIMINEN	/Siu Lee/	01/12/2007							

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

						SHEET	<u>1</u> OI	F 1	
NET (OF DDIOD AL	ATTY. DOCKET NO P-0588	APPLN. SERIAL NO. 10/696,997						
OF PRIOR ART CITED BY APPLICANT				APPLICANT(S) Jue-Cheol LEE					
MAR ? 9 2004	(PTO-1449)			FILING DATE 10/31/2003	GROUP 2631				
		HANNE UK	S. PATENT DO	OGUMENTS					
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE		ITOR NAME	CLASS	SUBCLASS	FILIN DAT		
	 		<u> </u>		 	ļ			
				ION PUBLICATIO		ALCONOL MAN		P 37 %	
	PATENT	USSEAUER 	III ARKEICAIII	ONIPUBLICAME	NO SALESTAN	The same of the same		£2385863	
	APPLN.	PUB. DATE	*AP	PLICANT	CLASS	SUBCLASS			
	, , , , ,								
				PLICATIONS A		ETHWY THE			
	APPLN.	*FILING	SPATENTAL	PLICATIONS				A Relation	
	NO.	DATE	*IN'	VENTOR	CLASS	SUBCLASS			
	-				-				
		FORE	IGNIPATENT	DOCUMENTS					
EXAMINER'S	DATENT NO			COUNTRY CLASS		SUBCLASS	Transla Yes	ation No	
INITIALS SL	PATENT NO. 0 372 759 A2	6/13/90	EPO	JOUNTRY			Tes	NO	
SL	WO03/039043 A1		WIPO						
					 	 	 		
					1.849			I	
		E PRIO	RARTCI	TEDIBYAP	PLICAI	UTTO TO LIST			
第二次						da H			
			// ((PTO±1/	STATE OF THE PARTY OF THE PARTY.	TE THE REAL				
OTHER/	ART (including Au				ner, Placer	of Publicatio	n,(Etc.)		
SL	European Patent Office Search Report dated 1/19/04								

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

EXAMINER

/Siu Lee/

DATE CONSIDERED

01/12/2007